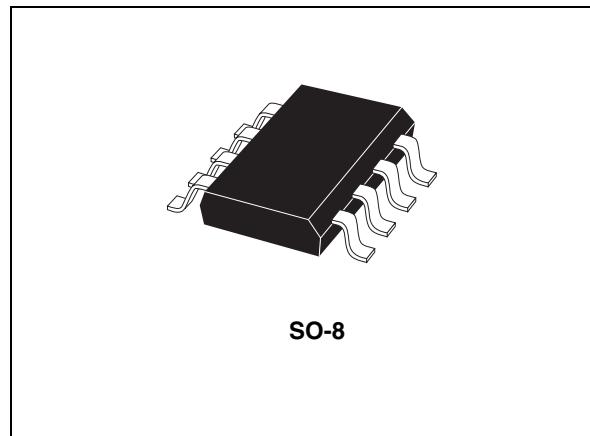


Dual-line programmable transient voltage suppressor for SLIC protection

Features

- dual-line programmable transient voltage suppressor
- wide negative firing voltage range
- $V_{MGL} = -150$ V max.
- low dynamic switching voltages: V_{FP} and V_{DGL}
- low gate triggering current: $I_{GT} = 5$ mA max.
- peak pulse current: $I_{PP} = 20$ A (10/1000 μ s)
- holding current: $I_H = 150$ mA min.



Benefits

- A Trisil™ is not subject to ageing and provides a fail safe mode in short circuit for better protection.
- Trisils are used to help equipment meet various standards such as UL1950, IEC 950 / CSA C22.2, UL1459 and FCC part68.
- Trisils have UL94 V0 approved resin.
- Trisils are UL497B approved (file: E136224).

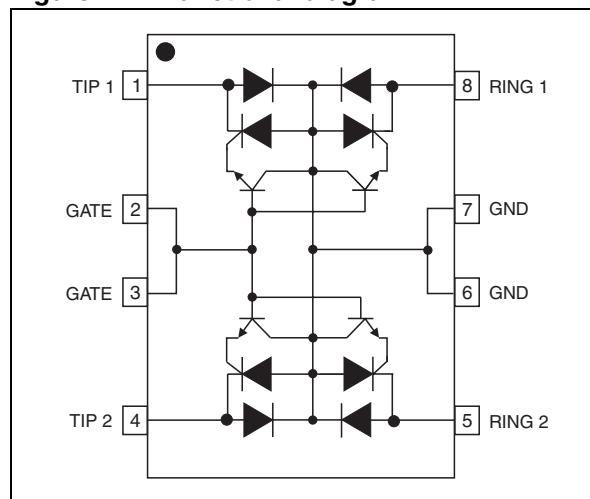
Description

This device has been designed to protect 2 new high voltage, as well as classical SLICs against transient overvoltages.

Positive overvoltages are clamped by 2 diodes. Negative surges are suppressed by 2 thyristors, their breakdown voltage being referenced to $-V_{BAT}$ through the gate.

This component presents a very low gate triggering current (I_{GT}) to reduce the current consumption on printed circuit boards during the firing phase.

Figure 1. Functional diagram



1 Compliant with the following standards

Table 1. Compliant with the following standards

| Standard | Peak surge voltage (V) | Voltage waveform | Required peak current (A) | Current waveform | Minimum serial resistor to meet standard (Ω) |
|--|------------------------|------------------|---------------------------|------------------|--|
| GR-1089 Core First level | 2500 | 2/10 µs | 500 | 2/10 µs | 31 |
| | 1000 | 10/1000 µs | 100 | 10/1000 µs | 40 |
| GR-1089 Core Second level | 5000 | 2/10 µs | 500 | 2/10 µs | 62 |
| GR-1089 Core Intra-building | 1500 | 2/10 µs | 100 | 2/10 µs | 7 |
| ITU-T-K20/K21 | 6000 | 10/700 µs | 150 | 5/310 µs | 200 |
| | 1500 | | 37.5 | | 20 |
| ITU-T-K20 (IEC 61000-4-2) | 8000 | 1/60 ns | ESD contact discharge | | 0 |
| | 15000 | | ESD air discharge | | 0 |
| VDE0433 | 4000 | 10/700 µs | 100 | 5/310 µs | 120 |
| | 2000 | | 50 | | 40 |
| VDE0878 | 4000 | 1.2/50 µs | 100 | 1/20 µs | 27 |
| | 2000 | | 50 | | 0 |
| IEC 61000-4-5 | 4000 | 10/700 µs | 100 | 5/310 µs | 120 |
| | 4000 | 1.2/50 µs | 100 | 8/20 µs | 27 |
| FCC Part 68, lightning surge type A | 1500 | 10/160 µs | 200 | 10/160 µs | 43 |
| | 800 | 10/560 µs | 100 | 10/560 µs | 32 |
| FCC Part 68, lightning surge type B | 1000 | 9/720 µs | 25 | 5/320 µs | 0 |

2 Characteristics

Table 2. Thermal resistance

| Symbol | Parameter | Value | Unit |
|----------------|---------------------|-------|------|
| R_{th} (j-a) | Junction to ambient | 170 | °C/W |

Figure 2. Electrical characteristics ($T_{amb} = 25$ °C)

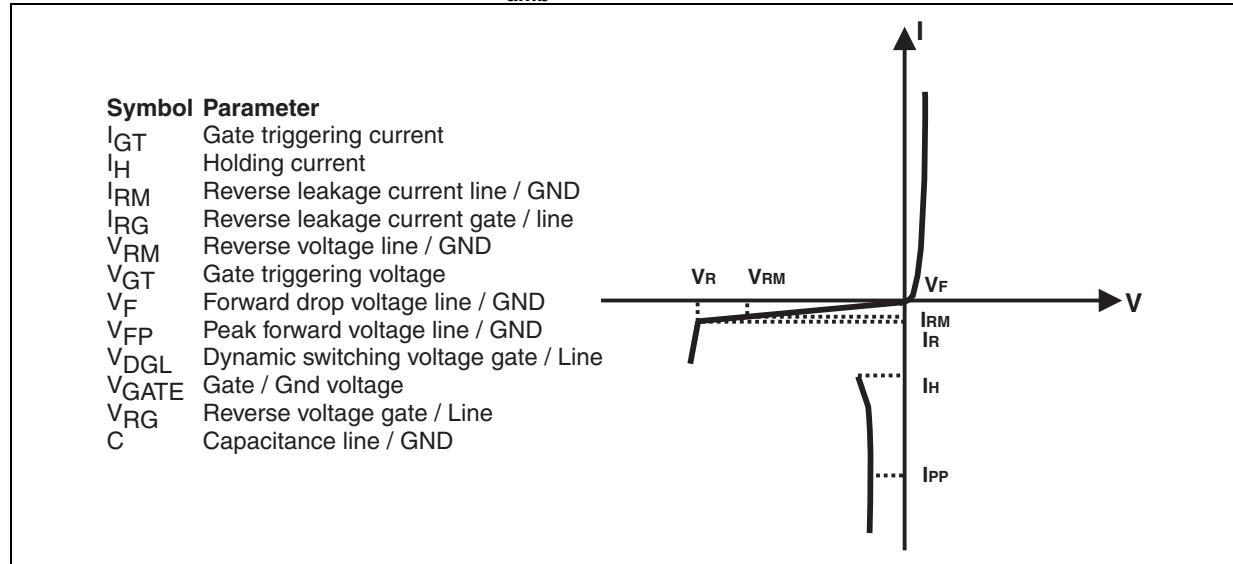
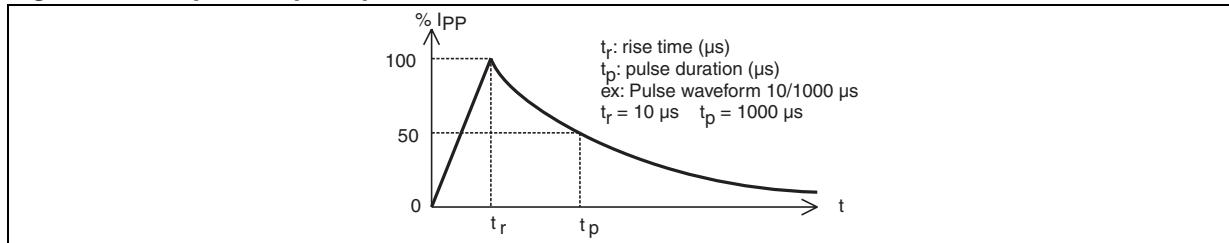


Table 3. Absolute ratings ($T_{amb} = 25$ °C, unless otherwise specified)

| Symbol | Parameter | Value | Unit | |
|------------------------|---|--|--|--------|
| I_{PP} | Peak pulse current ⁽¹⁾ | 10/1000 μ s 8/20 μ s 10/560 μ s 5/310 μ s 10/160 μ s 1/20 μ s 2/10 μ s | 20 60 20 25 30 60 70 | A |
| I_{TSM} | Non repetitive surge peak on-state current (50 Hz sinusoidal) | $t = 10$ ms $t = 1$ s | 5 3.5 | A |
| I^2t | I^2t value for fusing (50 Hz sinusoidal) | $t = 10$ ms | 0.125 | A^2s |
| I_{GSM} | Maximum gate current (50 Hz sinusoidal) | $t = 10$ ms | 2 | A |
| V_{MLG} V_{MGL} | Maximum voltage LINE/GND Maximum voltage GATE/LINE | -40 °C < T_{amb} < $+85$ °C -40 °C < T_{amb} < $+85$ °C | -150 -150 | V |
| T_{stg} T_j | Storage temperature range Maximum junction temperature | -55 to $+150$ 150 | °C | |
| T_L | Maximum lead temperature for soldering during 10 s | 260 | °C | |

1. For pulse waveform see [Figure 3](#).

Figure 3. Repetitive peak pulse current**Table 4. Parameters related to the diode line / GND (T_{amb} = 25 °C)**

| Symbol | Test conditions | | | | Max | Unit |
|--------------------------------|----------------------|--------|------------------------|------------------------|-----|------|
| V _F | I _F = 1 A | | t = 500 μs | | 2 | V |
| V _{FP} ⁽¹⁾ | 10/700 μs | 1.5 kV | R _S = 110 Ω | I _{PP} = 10 A | 5 | |
| | 1.2/50 μs | 1.5 kV | R _S = 60 Ω | I _{PP} = 15 A | 10 | |
| | 2/10 μs | 2.5 kV | R _S = 245 Ω | I _{PP} = 10 A | 20 | |

1. See [Figure 5: Test circuit for V_{FP} and V_{DGL} parameters](#). R_S is the protection resistor located on the line card.

Table 5. Parameters related to the protection thyristor (T_{amb} = 25°C unless otherwise specified)

| Symbol | Test conditions | | | | Min | Max | Unit |
|------------------|--|--------|------------------------|------------------------|-----|-----|------|
| I _{GT} | V _{GND / LINE} = -48 V | | | | 0.1 | 5 | mA |
| I _H | V _{GATE} = -48 V ⁽¹⁾ | | | | 150 | | mA |
| V _{GT} | At I _{GT} | | | | | 2.5 | V |
| I _{RG} | V _{RG} = -150 V | | T _c = 25 °C | | | 5 | |
| | V _{RG} = -150 V | | T _c = 85 °C | | | 50 | μA |
| V _{DGL} | V _{GATE} = -48 V ⁽²⁾ | | | | | | |
| | 10/700 μs | 1.5 kV | R _S = 110 Ω | I _{PP} = 10 A | | 5 | |
| | 1.2/50 μs | 1.5 kV | R _S = 60 Ω | I _{PP} = 15 A | | 10 | |
| | 2/10 μs | 2.5 kV | R _S = 245 Ω | I _{PP} = 10 A | | 20 | |

1. See [Figure 4: Functional holding current \(I_H\) test circuit: go no-go test](#)

2. See [Figure 5: Test circuit for V_{FP} and V_{DGL} parameters](#). The oscillations with a time duration lower than 50 ns are not taken into account

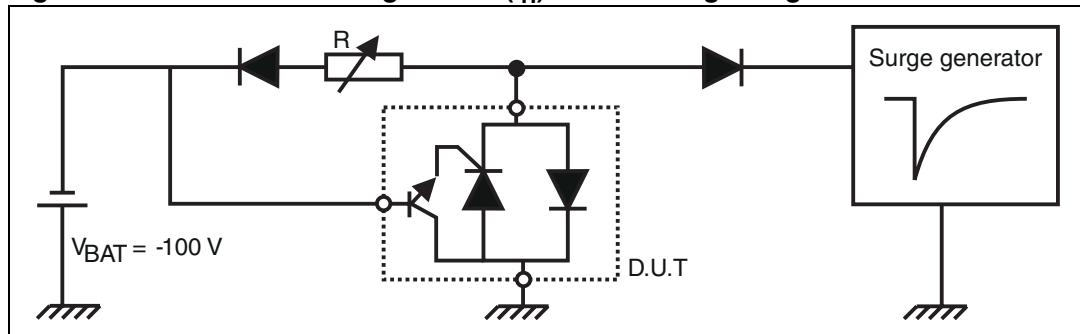
Table 6. Parameters related to diode and protection thyristor (T_{amb} = 25 °C, unless otherwise specified)

| Symbol | Test conditions | | Typ. | Max. | Unit |
|-----------------|---|------------------------|------|------|------|
| I _{RM} | V _{GATE / LINE} = -1 V V _{RM} = -150 V | T _c = 25 °C | | 5 | |
| | V _{GATE / LINE} = -1 V V _{RM} = -150 V | T _c = 85 °C | | 50 | μA |
| C | V _R = 50 V bias, V _{RMS} = 1 V, F = 1 MHz | | 20 | | |
| | V _R = 2 V bias, V _{RMS} = 1 V, F = 1 MHz | | 48 | | pF |

3 Test circuits

3.1 Functional holding current (I_H): go no-go test

Figure 4. Functional holding current (I_H) test circuit: go no-go test



This is a go no-go test, which confirms the holding current (I_H) level in a functional test circuit.

3.1.1 Test procedure

- Adjust the current level at the I_H value by short circuiting the D.U.T.
- Fire the D.U.T. with a surge current: $I_{PP} = 10 \text{ A}, 10/1000 \mu\text{s}$.

The D.U.T. will come back to the off-state within a duration of 50 ms max.

3.2 Test circuit for V_{FP} and V_{DGL} parameters

Figure 5. Test circuit for V_{FP} and V_{DGL} parameters

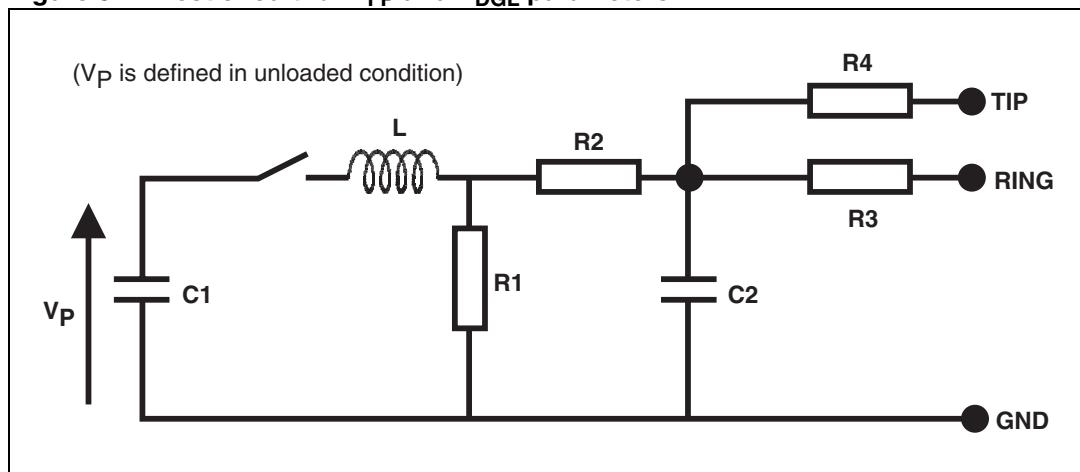


Table 7. Test circuit component values

| Pulse (μs) | | V _p | C ₁ | C ₂ | L | R ₁ | R ₂ | R ₃ | R ₄ | I _{PP} | R _s |
|----------------|----------------|----------------|----------------|----------------|------|----------------|----------------|----------------|----------------|-----------------|----------------|
| t _r | t _p | (V) | (μF) | (nF) | (μH) | (Ω) | (Ω) | (Ω) | (Ω) | (A) | (Ω) |
| 10 | 700 | 1500 | 20 | 200 | 0 | 50 | 15 | 25 | 25 | 10 | 110 |
| 1.2 | 50 | 1500 | 1 | 33 | 0 | 76 | 13 | 25 | 25 | 15 | 60 |
| 2 | 10 | 2500 | 10 | 0 | 1.1 | 1.3 | 0 | 3 | 3 | 10 | 245 |

4 Technical information

Figure 6. LCDP1521 concept behavior

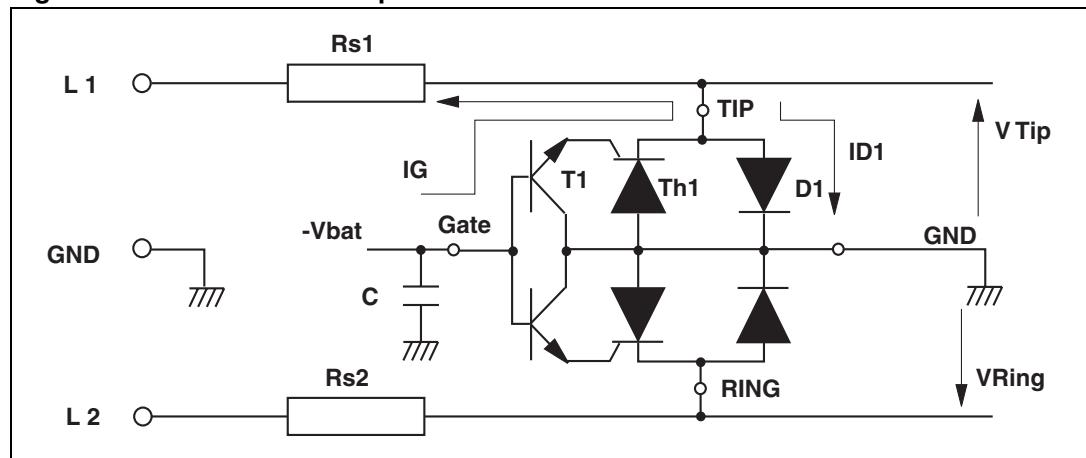


Figure 6 shows the classic protection circuit using the LCDP1521 crowbar concept. This topology has been developed to protect the new high voltage SLICs. This supports the programming of the negative firing threshold while the positive clamping value is fixed at GND.

When a negative surge occurs on one wire (L1 for example), a current I_G flows through the base of the transistor T1 and then injects a current in the gate of the thyristor Th1. Th1 fires and all the surge current flows through the ground. After the surge when the current flowing through Th1 becomes less negative than the holding current I_H , then Th1 switches off.

When a positive surge occurs on one wire (L1 for example), the diode D1 conducts and the surge current flows through the ground.

The capacitor C is used to speed up the crowbar structure firing during the fast surge edges.

This minimizes the dynamic breakdown voltage at the SLIC Tip and Ring inputs during fast strikes. Note that this capacitor is generally present around the SLIC - V_{BAT} pin.

So, to be efficient, it has to be as close as possible to the LCDP1521 Gate pin and to the reference ground track (or plan). The optimized value for C is 220 pF.

The series resistors $Rs1$ and $Rs2$ in *Figure 6* represent the fuse resistors or the PTC which are mandatory to withstand the power contact or the power induction tests imposed by the

various country standards. Taking into account this fact, the actual lightning surge current flowing through the LCDP is equal to:

$$I_{\text{surge}} = V_{\text{surge}} / (R_g + R_s)$$

With:

V_{surge} = peak surge voltage imposed by the standard.

R_g = series resistor of the surge generator

R_s = series resistor of the line card (equivalent to PTC + R in [Figure 7](#))

Example: For a line card with 60Ω of series resistors, which has to be qualified under GR-1089 Core 1000 V, 10/1000 μ s surge, the actual current through the LCDP1521 is equal to:

$$I_{\text{surge}} = 1000 / (10 + 60) = 14 \text{ A}$$

The LCDP1521 is particularly optimized for the new telecom applications such as the fiber in the loop, the WLL, and the remote central office. In this case the operating voltages are smaller than in the classic system. This makes the high voltage SLICs particularly suitable. The schematics of [Figure 7](#) show the topologies most frequently used for these applications.

Figure 7. Protection of high voltage SLICs

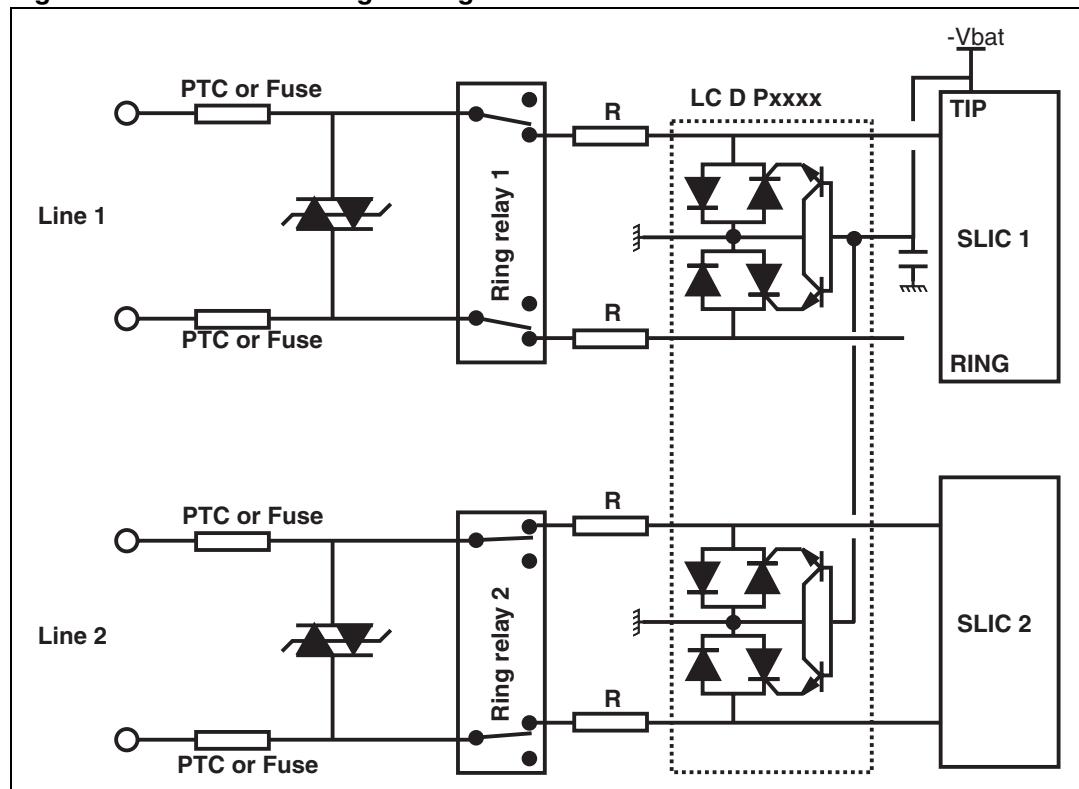
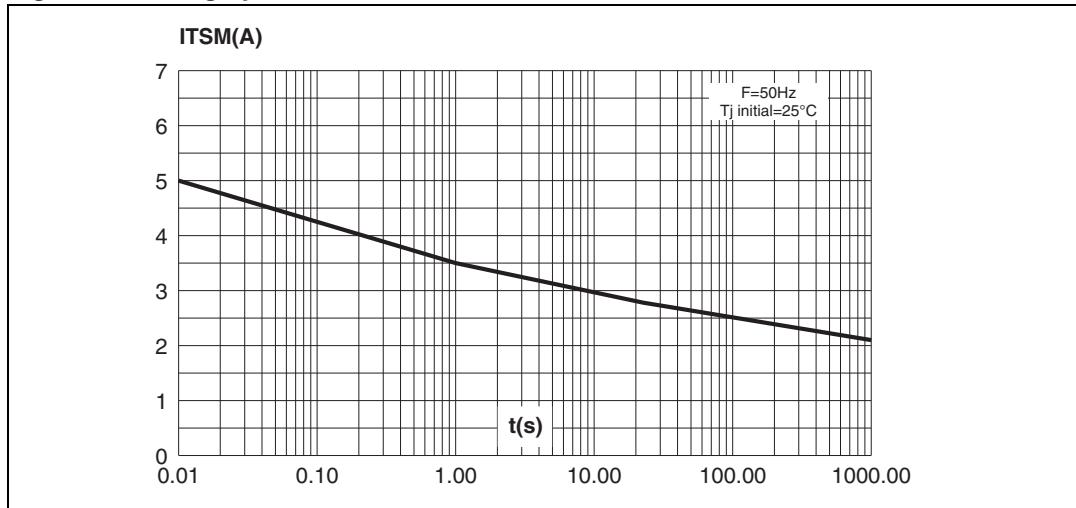
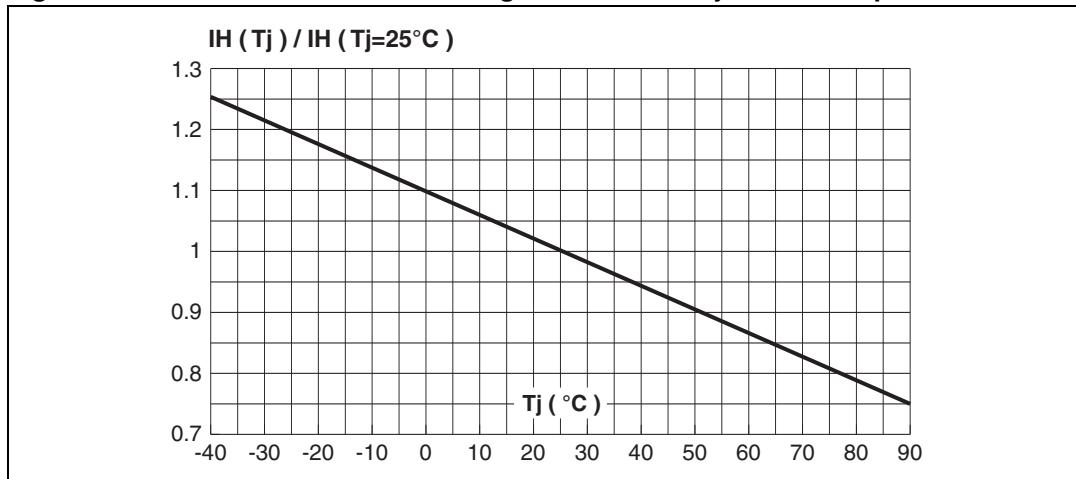
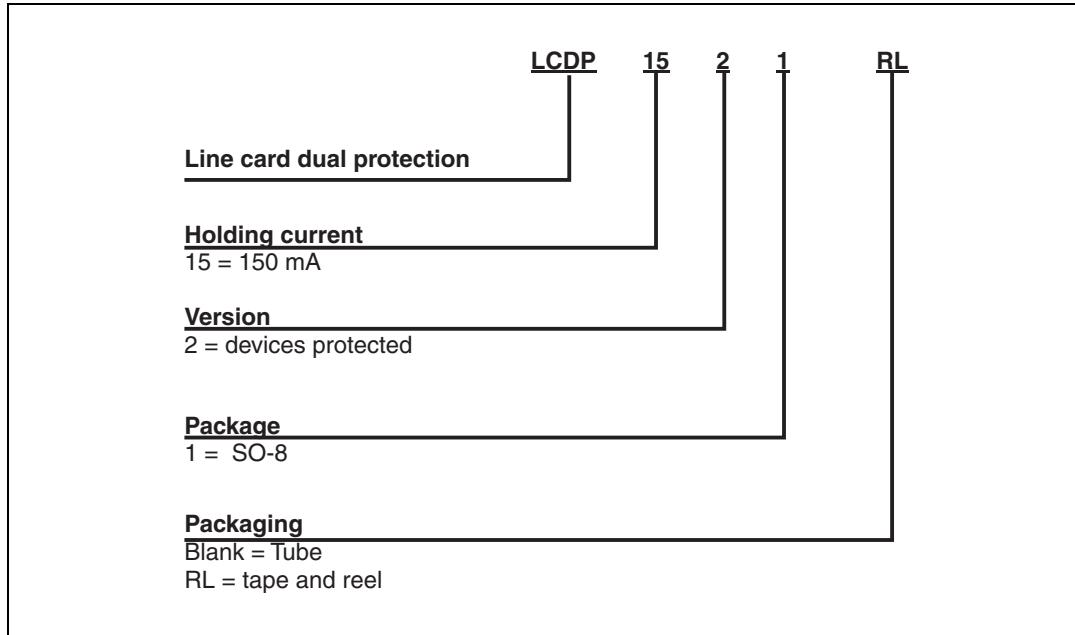


Figure 8. Surge peak current versus overload duration.**Figure 9. Relative variation of holding current versus junction temperature**

5 Ordering information scheme

Figure 10. Ordering information scheme



6 Package information

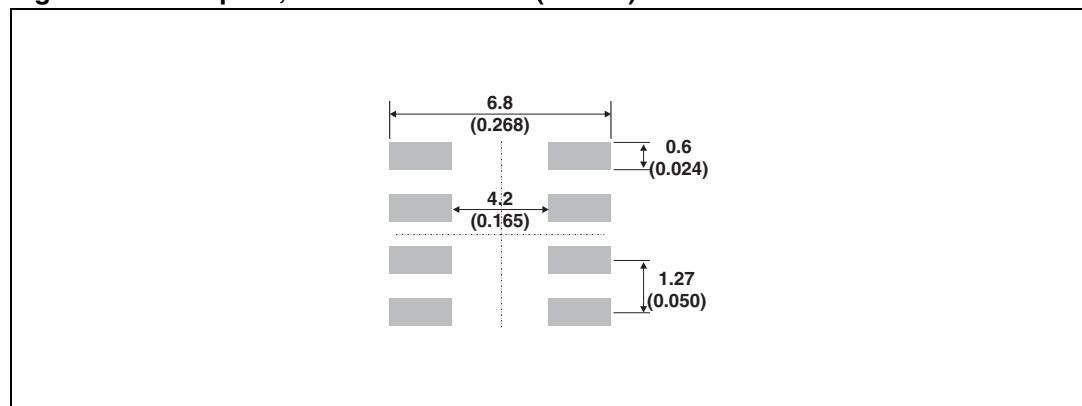
- Epoxy meets UL94, V0
- Lead-free package

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Table 8. SO-8 dimensions

| Ref. | Dimensions | | | | | |
|------|-------------|------|------|--------|-------|-------|
| | Millimeters | | | Inches | | |
| | Min. | Typ. | Max. | Min. | Typ. | Max. |
| A | | | 1.75 | | | 0.069 |
| A1 | 0.1 | | 0.25 | 0.004 | | 0.010 |
| A2 | 1.25 | | | 0.049 | | |
| b | 0.28 | | 0.48 | 0.011 | | 0.019 |
| C | 0.17 | | 0.23 | 0.007 | | 0.009 |
| D | 4.80 | 4.90 | 5.00 | 0.189 | 0.193 | 0.197 |
| E | 5.80 | 6.00 | 6.20 | 0.228 | 0.236 | 0.244 |
| E1 | 3.80 | 3.90 | 4.00 | 0.150 | 0.154 | 0.157 |
| e | | 1.27 | | | 0.050 | |
| h | 0.25 | | 0.50 | 0.010 | | 0.020 |
| L | 0.40 | | 1.27 | 0.016 | | 0.050 |
| L1 | | 1.04 | | | 0.041 | |
| k | 0° | | 8° | 0° | | 8° |
| ppp | | | 0.10 | | | 0.004 |

Figure 11. Footprint, dimensions in mm (inches)



7 Ordering Information

Table 9. Ordering information

| Order code | Marking | Package | Weight | Base qty | Delivery mode |
|---------------------------|---------|---------|--------|----------|---------------|
| LCDP1521 | CDP152 | SO-8 | 0.08 g | 100 | Tube |
| LCDP1521RL ⁽¹⁾ | | | | 2500 | Tape and reel |

1. Preferred device

8 Revision history

Table 10. Document revision history

| Date | Revision | Changes |
|-------------|----------|---|
| March 2002 | 1 | Initial release. |
| 24-Jun-2005 | 2 | Peak pulse current changed from 15 to 20 A (10/1000 µs) |
| 07-Feb-2006 | 3 | Added footnote to ordering information table |
| 20-Oct-2010 | 4 | Updated ECOPACK statement. Updated trademark statement. |

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